



**CHENMKO ENTERPRISE CO.,LTD**

Halogens free devices

**SURFACE MOUNT  
NPN General Purpose Transistor**

**VOLTAGE 45 Volts CURRENT 0.1 Ampere**

**CHT847BTGP**

#### APPLICATION

- \* AF input stages and driver applicationon equipment.
- \* Other general purpose applications.

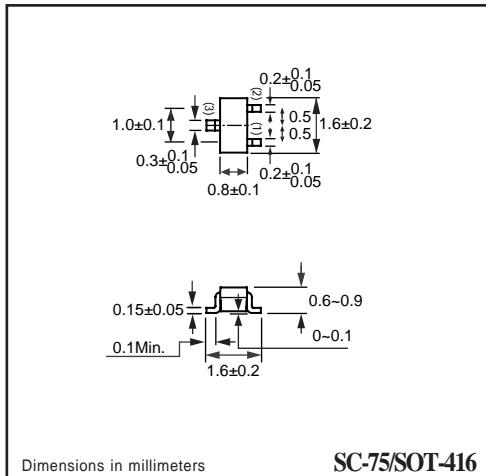
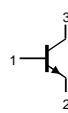
#### FEATURE

- \* Surface mount package. (SC-75/SOT-416)
- \* High current gain.
- \* Suitable for high packing density.
- \* Low collector-emitter saturation.
- \* High saturation current capability.

#### MARKING

- \* HFE (Q):XC
- \* HFE (R):YC
- \* HFE (S):ZC

#### CIRCUIT



#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{CBO}$	collector-base voltage	open emitter	–	50	V
$V_{CEO}$	collector-emitter voltage	open base	–	45	V
$V_{EBO}$	emitter-base voltage	open collector	–	6	V
$I_C$	collector current (DC)		–	0.1	A
$P_C$	Collector power dissipation		–	0.15	W
		Note2	–	0.2	
$T_{stg}$	storage temperature		-55	+150	°C
$T_j$	junction temperature		–	150	°C

#### Note

1. Transistor mounted on an FR4 printed-circuit board.
2. When mounted on a 7X5X0.6mm ceramic board.

## RATING CHARACTERISTIC ( CHT847BTGP )

### THERMAL CHARACTERISTICS CHARACTERISTICS

$T_{amb} = 25^{\circ}\text{C}$  unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	Typ.	MAX.	UNIT
$I_{CBO}$	collector cut-off current	$I_E = 0; V_{CB} = 30\text{ V}$	—	—	15	nA
		$I_C = 0; V_{CB} = 30\text{ V}; T_A = 150^{\circ}\text{C}$	—	—	5	uA
$BVCBO$	collector-base breakdown voltage	$I_C = 50\text{ uA}$	50	—	—	V
$BVCEO$	collector-emitter breakdown voltage	$I_C = 1\text{ mA}$	45	—	—	V
$BVEBO$	emitter-base breakdown voltage	$I_E = 50\text{ uA}$	6	—	—	V
$h_{FE}$	DC current transfer ratio	$V_{CE}/I_C = 5\text{ V}/2\text{ mA}$	110	—	800	
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = 10\text{ mA}; I_B = 0.5\text{ mA}$	—	—	250	mV
		$I_C = 100\text{ mA}; I_B = 5\text{ mA}$	—	—	600	mV
$V_{BE(on)}$	base-emitter saturation voltage	$I_C = 10\text{ mA}; V_{CE} = 5.0\text{ V}$	0.58	—	0.77	V
$C_{ib}$	emitter input capacitance	$I_E = 0; V_{CB} = 0.5\text{ V}; f = 1\text{ MHz}$	—	8	—	pF
$C_{ob}$	collector output capacitance	$I_E = 0; V_{CB} = -10\text{ V}; f = 1\text{ MHz}$	—	3	—	pF
$f_T$	transition frequency	$I_E = -20\text{ mA}; V_{CE} = 5\text{ V}; f = 100\text{ MHz}$	—	200	—	MHz

### Note

1. Pulse test:  $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$ .
2. hFE: Classification Q: 110 to 220, R: 200 to 450, S: 420 to 800

## RATING CHARACTERISTIC CURVES ( CHT847BTGP )

fig1.Grounded emitter output characteristics

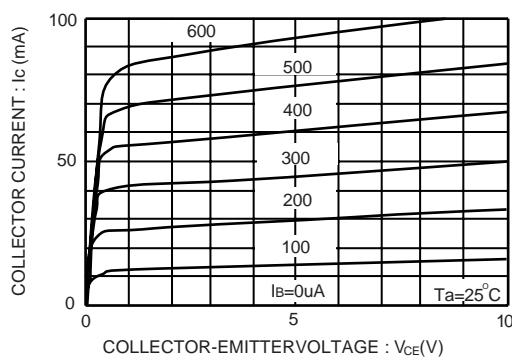
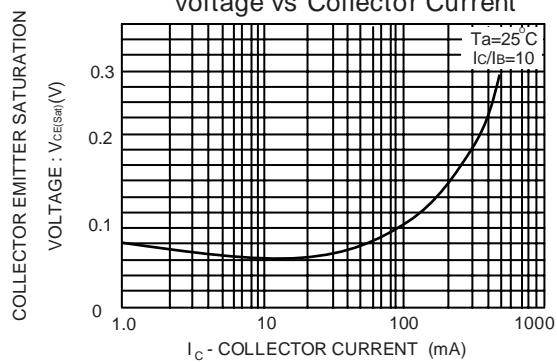


fig2.Collector-Emitter Saturation Voltage vs Collector Current



## RATING CHARACTERISTIC CURVES ( CHT847BTGP )

fig3.DC current gain VS. collector current (1)

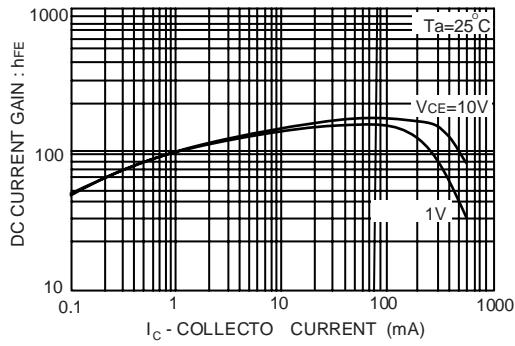


fig4.DC current gain VS. collector current (2)

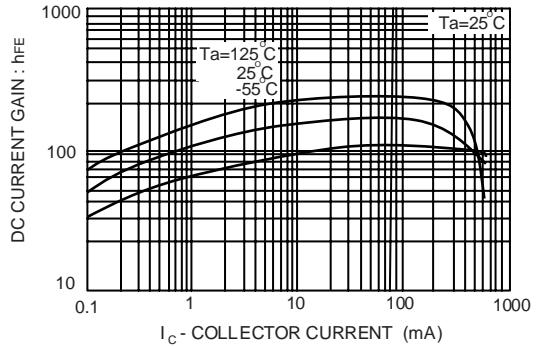


fig5.AC current gain VS. collector current

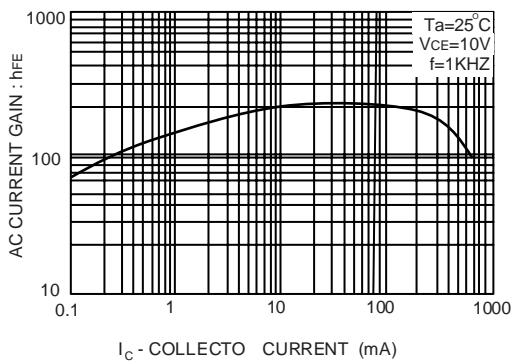


fig6.Base-emitter saturation voltage VS. collector current

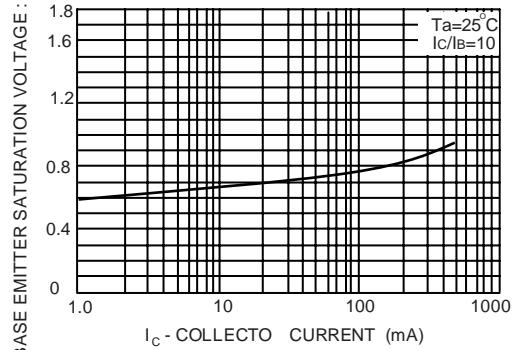


fig7.Grounded emitter propagation characteristics

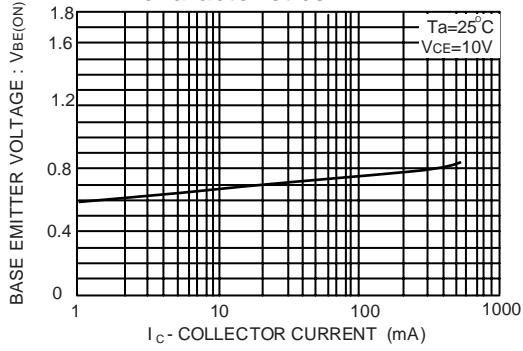
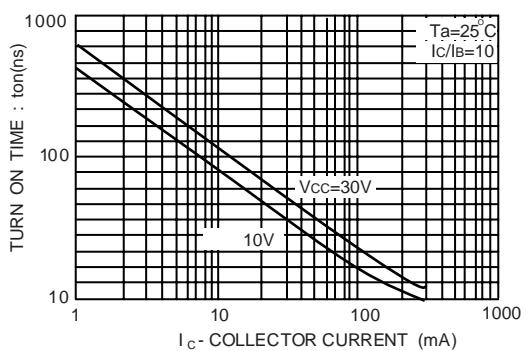


fig8.Turn-on time VS. collector current



## RATING CHARACTERISTIC CURVES ( CHT847BTGP )

fig9.Rise time VS. collector current

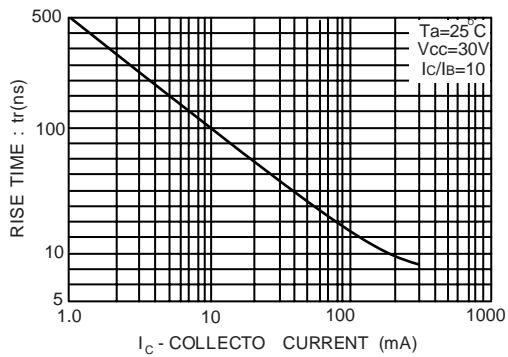


fig10.Fall time VS. collector current

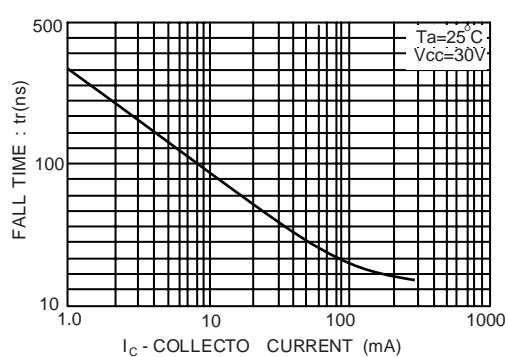


fig11.Input / output capacitance VS. voltage

